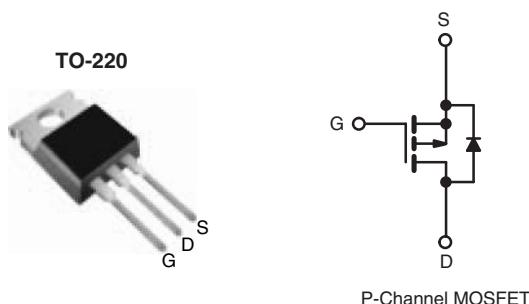


## Power MOSFET

PRODUCT SUMMARY	
V <sub>DS</sub> (V)	- 100
R <sub>D(on)</sub> (Ω)	V <sub>GS</sub> = - 10 V      0.60
Q <sub>g</sub> (Max.) (nC)	18
Q <sub>gs</sub> (nC)	3.0
Q <sub>gd</sub> (nC)	9.0
Configuration	Single



### FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- 175 °C Operating Temperature
- Fast Switching
- Ease of Parallelizing
- Simple Drive Requirements
- Lead (Pb)-free Available


**RoHS\***  
COMPLIANT

### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220
Lead (Pb)-free	IRF9520PbF SiHF9520-E3
SnPb	IRF9520 SiHF9520

ABSOLUTE MAXIMUM RATINGS T <sub>C</sub> = 25 °C, unless otherwise noted					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	- 100		
Gate-Source Voltage		V <sub>GS</sub>	± 20	V	
Continuous Drain Current	V <sub>GS</sub> at - 10 V	T <sub>C</sub> = 25 °C	I <sub>D</sub>	A	
		T <sub>C</sub> = 100 °C	- 6.8		
Pulsed Drain Current <sup>a</sup>		I <sub>DM</sub>	- 27		
Linear Derating Factor			0.40	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	300	mJ	
Repetitive Avalanche Current <sup>c</sup>		I <sub>AR</sub>	- 6.8	A	
Repetitive Avalanche Energy <sup>c</sup>		E <sub>AR</sub>	6.0	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	P <sub>D</sub>	60	W	
Peak Diode Recovery dV/dt <sup>c</sup>		dV/dt	- 5.5	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw		10	lbf · in	
			1.1	N · m	

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- V<sub>DD</sub> = - 25 V, starting T<sub>J</sub> = 25 °C, L = 9.7 mH, R<sub>G</sub> = 25 Ω, I<sub>AS</sub> = - 6.8 A (see fig. 12).
- I<sub>SD</sub> ≤ - 6.8 A, dI/dt ≤ 110 A/μs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 175 °C.
- 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

**THERMAL RESISTANCE RATINGS**

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	62	°C/W
Case-to-Sink, Flat, Greased Surface	$R_{thCS}$	0.50	-	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	2.5	

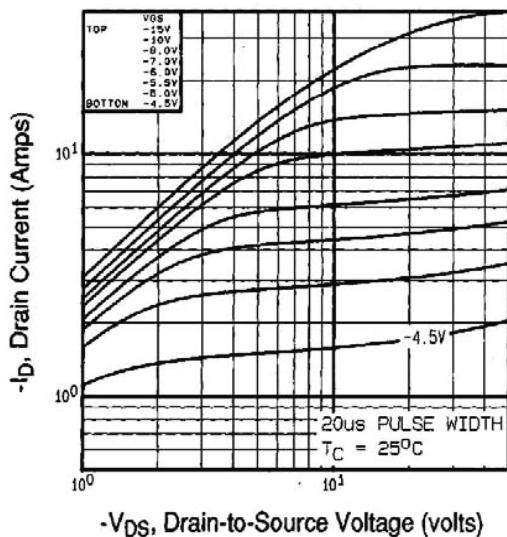
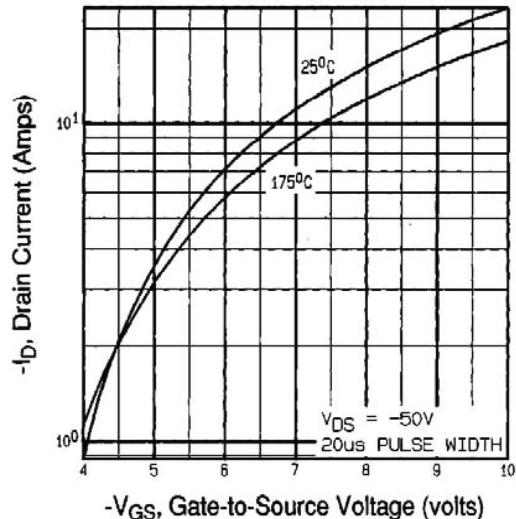
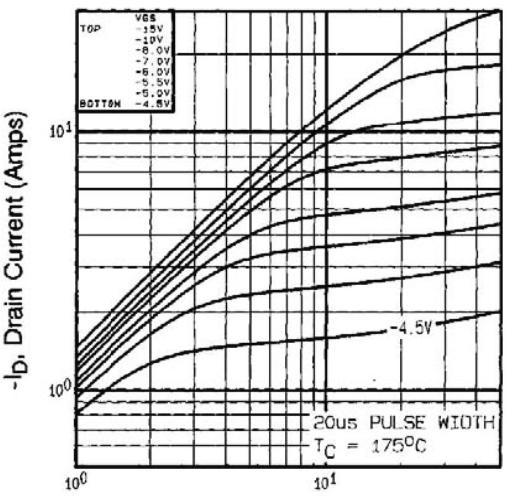
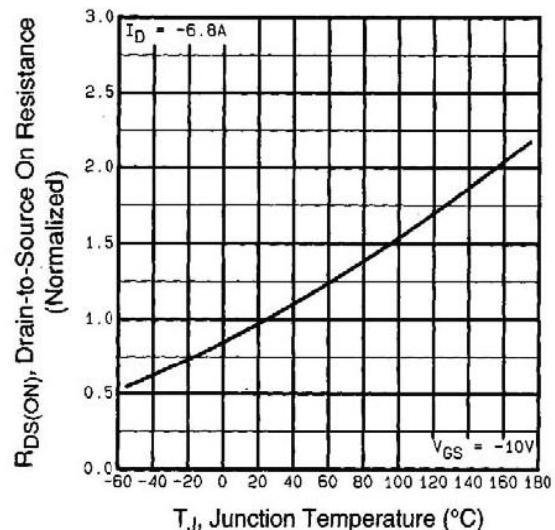
**SPECIFICATIONS**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
<b>Static</b>								
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}$ , $I_D = -250 \mu\text{A}$		-100	-	-	V	
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to $25^\circ\text{C}$ , $I_D = -1 \text{ mA}$		-	-0.10	-	$\text{V}/^\circ\text{C}$	
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}$ , $I_D = -250 \mu\text{A}$		-2.0	-	-4.0	V	
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20 \text{ V}$		-	-	$\pm 100$	nA	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -100 \text{ V}$ , $V_{GS} = 0 \text{ V}$		-	-	-100	$\mu\text{A}$	
		$V_{DS} = -80 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_J = 150^\circ\text{C}$		-	-	-500		
Drain-Source On-State Resistance	$R_{DS(\text{on})}$	$V_{GS} = -10 \text{ V}$	$I_D = -4.1 \text{ A}^b$	-	-	0.60	$\Omega$	
Forward Transconductance	$g_{fs}$	$V_{DS} = -50 \text{ V}$ , $I_D = -4.1 \text{ A}^b$		2.0	-	-	S	
<b>Dynamic</b>								
Input Capacitance	$C_{iss}$	$V_{GS} = 0 \text{ V}$ , $V_{DS} = -25 \text{ V}$ , $f = 1.0 \text{ MHz}$ , see fig. 5		-	390	-	pF	
Output Capacitance	$C_{oss}$			-	170	-		
Reverse Transfer Capacitance	$C_{rss}$			-	45	-		
Total Gate Charge	$Q_g$	$V_{GS} = -10 \text{ V}$	$I_D = -6.8 \text{ A}$ , $V_{DS} = -80 \text{ V}$ , see fig. 6 and 13 <sup>b</sup>	-	-	18	nC	
Gate-Source Charge	$Q_{gs}$			-	-	3.0		
Gate-Drain Charge	$Q_{gd}$			-	-	9.0		
Turn-On Delay Time	$t_{d(\text{on})}$			-	9.6	-		
Rise Time	$t_r$	$V_{DD} = -50 \text{ V}$ , $I_D = -6.8 \text{ A}$ , $R_G = 18 \Omega$ , $R_D = 7.1 \Omega$ , see fig. 10 <sup>b</sup>		-	29	-	ns	
Turn-Off Delay Time	$t_{d(\text{off})}$			-	21	-		
Fall Time	$t_f$			-	25	-		
Internal Drain Inductance	$L_D$			-	4.5	-	nH	
Internal Source Inductance	$L_S$	Between lead, 6 mm (0.25") from package and center of die contact		-	7.5	-		
<b>Drain-Source Body Diode Characteristics</b>								
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode		-	-	-6.8	A	
Pulsed Diode Forward Current <sup>a</sup>	$I_{SM}$			-	-	-27		
Body Diode Voltage	$V_{SD}$	$T_J = 25^\circ\text{C}$ , $I_S = -6.8 \text{ A}$ , $V_{GS} = 0 \text{ V}^b$		-	-	-6.3	V	
Body Diode Reverse Recovery Time	$t_{rr}$	$T_J = 25^\circ\text{C}$ , $I_F = -6.8 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	98	200	ns	
Body Diode Reverse Recovery Charge	$Q_{rr}$			-	0.33	0.66	$\mu\text{C}$	
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )						

**Notes**

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq 300 \mu\text{s}$ ; duty cycle  $\leq 2\%$ .

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

**Fig. 1 - Typical Output Characteristics,  $T_C = 25^\circ\text{C}$** 

**Fig. 3 - Typical Transfer Characteristics**

**Fig. 2 - Typical Output Characteristics,  $T_C = 175^\circ\text{C}$** 

**Fig. 4 - Normalized On-Resistance vs. Temperature**

# IRF9520, SiHF9520

Vishay Siliconix

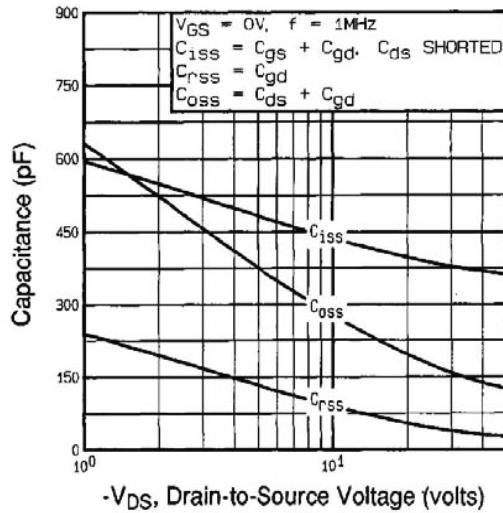


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

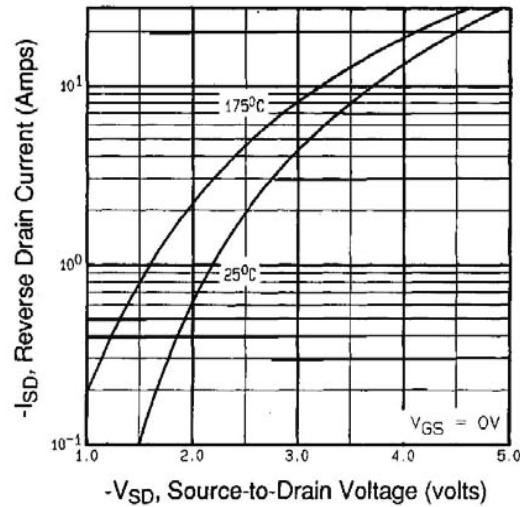


Fig. 7 - Typical Source-Drain Diode Forward Voltage

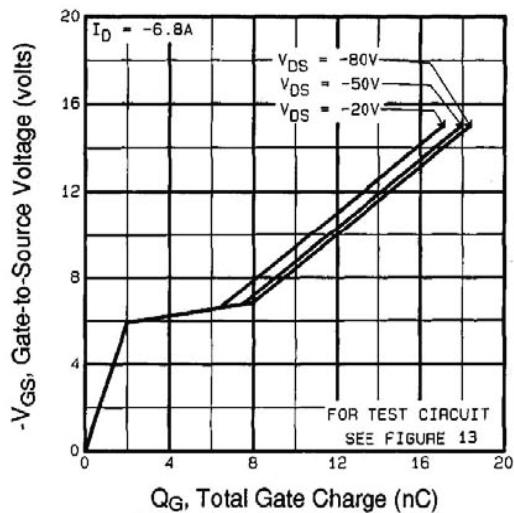


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

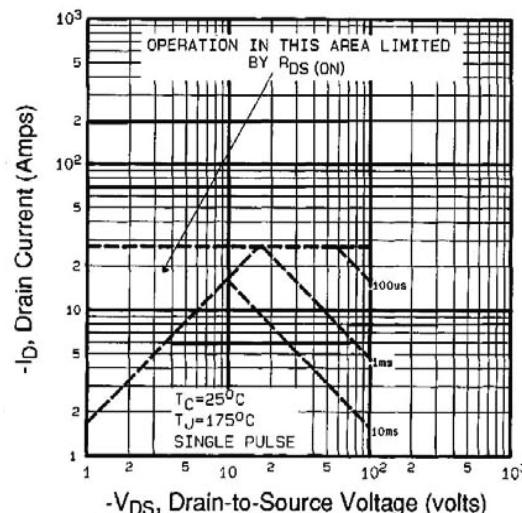


Fig. 8 - Maximum Safe Operating Area

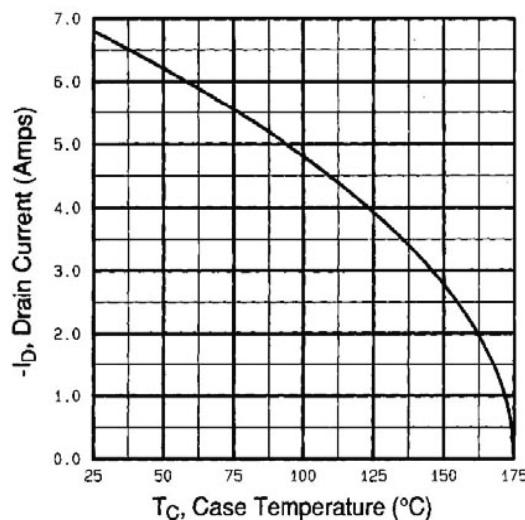


Fig. 9 - Maximum Drain Current vs. Case Temperature

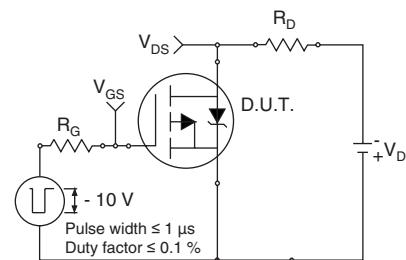


Fig. 10a - Switching Time Test Circuit

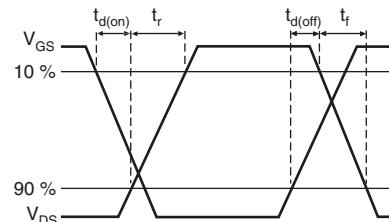


Fig. 10b - Switching Time Waveforms

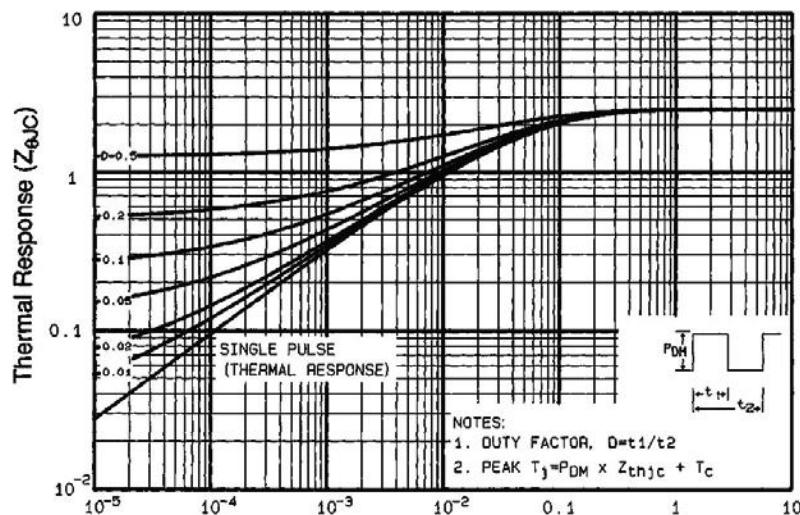


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

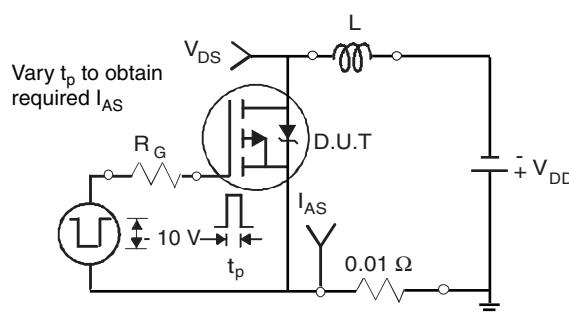


Fig. 12a - Unclamped Inductive Test Circuit

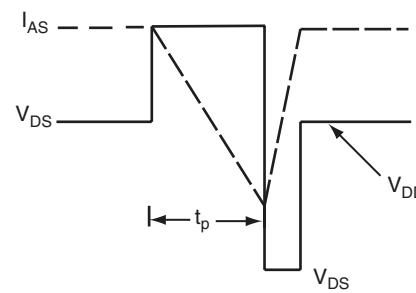
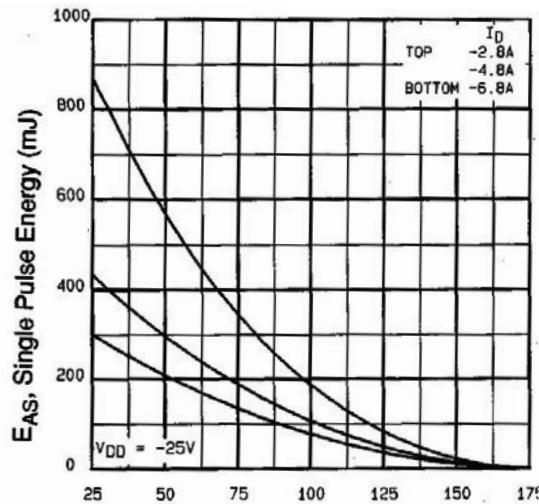


Fig. 12b - Unclamped Inductive Waveforms



Starting  $T_J$ , Junction Temperature( $^{\circ}$ C)  
Fig. 12c - Maximum Avalanche Energy vs. Drain Current

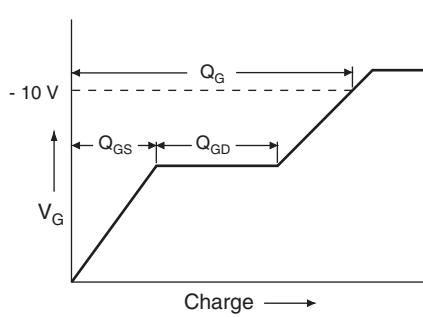


Fig. 13a - Basic Gate Charge Waveform

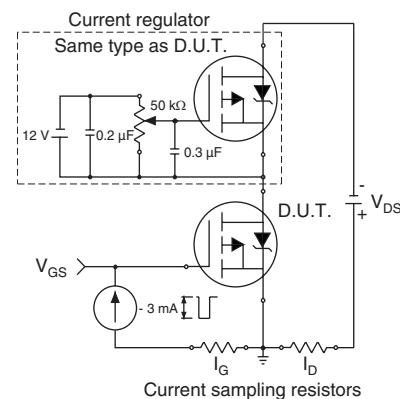
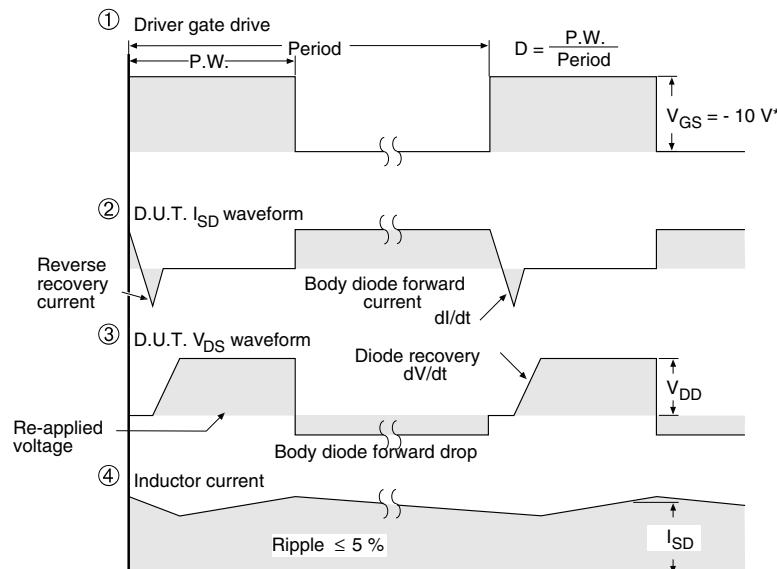
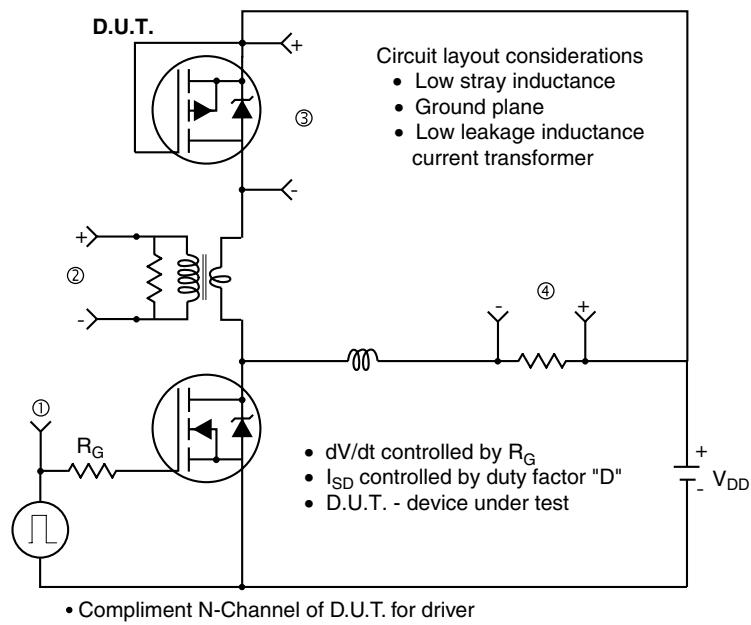


Fig. 13b - Gate Charge Test Circuit

### Peak Diode Recovery dV/dt Test Circuit



\*  $V_{GS} = -5 \text{ V}$  for logic level and -3 V drive devices

Fig. 14 - For P-Channel



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